

600V Super-Junction Power MOSFET

DESCRIPTION

600V Super-junction Power MOSFET

Super-junction power MOSFET is a revolutionary technology for high voltage power MOSFETs, designed according to the SJ principle and pioneered. The Multi-EPI SJ MOSFET provide an extremely fast and robust body diode. Also provide an extremely low switching, communication and conduction losses device with highest robustness make especially resonant switching applications more reliable, more efficient, lighter and cooler, designed by Wuxi Unigroup Microelectronics Company.

APPLICATIONS

LLC Half-bridge

Charger

Switch Mode Power Supply (SMPS)

Uninterruptible Power Supply (UPS)

Power Factor Correction (PFC)

FEATURES

- Ultra-fast body diode
- Very low FOM R_{DS(on)}×Q_g
- Easy to use/drive
- 100% avalanche tested
- RoHS compliant



Drain Gate

Source



Device Marking and Package Information				
Device	Package	Marking		
TPA60R360MFD	TO-220F	60R360MFD		
Key Performance Para	meters	· · · · · · · · · · · · · · · · · · ·		
Parameter	Value	Unit		
V _{DS} @ T _{j,max}	600	V		
R _{DS(on),max}	0.36	Ω		
I _D	11	A		
Q _{g,typ}	20.5	nC		
I _{DM}	33	A		
t _{rr}	119	ns		
Q _{rr}	0.58	μC		
I _{rrm}	9.8	А		



Absolute Maximum Ratings $T_c = 25^{\circ}C$, unless otherwise noted				
Parameter		Symbol	Value	Unit
Drain-Source Voltage (V _{GS} = 0V)		V _{DSS}	600	V
Continuous Drain Current	T _C = 25°C	I _D	11	А
	TC = 100°C		6.6	
Pulsed Drain Current (note1)		I _{DM}	33	А
Gate-Source Voltage		V _{GSS}	±30	V
Single Pulse Avalanche Energy (note2)		E _{AS}	210	mJ
Repetitive Avalanche Energy (note2)		E _{AR}	0.32	mJ
Avalanche Current		I _{AR}	1.8	А
MOSFET dv/dt ruggedness, V _{DS} = 0480V		dv/dt	50	V/ns
Power Dissipation		P _D	31	W
Continuous Body Diode Current		۱ _s	11	
Pulsed Diode Forward Current (note1)		I _{SM}	33	A
Reverse diode dv/dt (note3)		dv/dt	50	V/ns
Maximum diode commutation speed (note3)		di _f /dt	900	A/us
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55~+150	°C

Thermal Resistance				
Parameter	Symbol	Value	Unit	
Thermal Resistance, Junction-to-Case R _{thJC} 4		4	00.000	
Thermal Resistance, Junction-to-Ambient	R _{thJA}	80	°C/W	



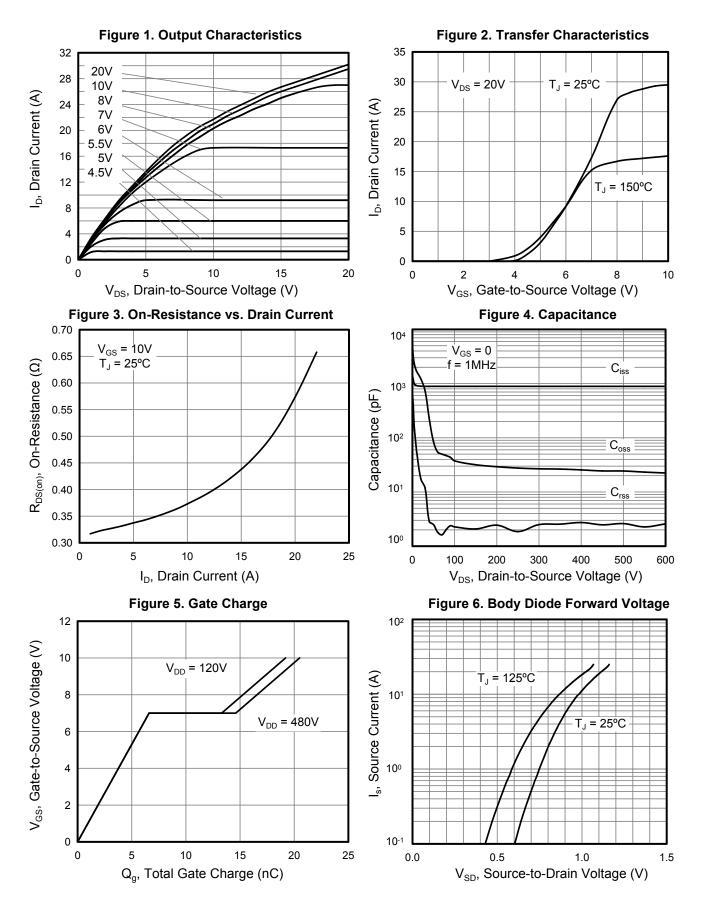
		Tool Constitutions	Value				
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	•	· · · · · ·		•			
Drain-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0V, I_{D} = 250\mu A$	600			V	
Zara Cata Valtara Ducia Curra I		V_{DS} = 600V, V_{GS} = 0V, T_{J} = 25°C			1.25	μA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 600V, V _{GS} = 0V, T _J = 150°C			1250		
Gate-Source Leakage	I _{GSS}	V_{GS} = $\pm 30V$			±100	nA	
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	3		5	V	
Drain-Source On-Resistance	$R_{DS(on)}$	V _{GS} = 10V, I _D = 5.5A		0.33	0.36	Ω	
Gate resistance	R _G	f = 1.0MHz open drain		18		Ω	
Dynamic	1						
Input Capacitance	C _{iss})/ _ O)/		890			
Output Capacitance	C _{oss}	$V_{GS} = 0V,$ $V_{DS} = 100V,$		38		pF	
Reverse Transfer Capacitance	C _{rss}	f = 1.0MHz		2			
Total Gate Charge	Qg			20.5		nC	
Gate-Source Charge	Q _{gs}	$V_{DD} = 480V, I_{D} = 11A, V_{GS} = 10V$		6.6			
Gate-Drain Charge	Q _{gd}			8.0			
Turn-on Delay Time	t _{d(on)}			23			
Turn-on Rise Time	t _r	V _{DD} = 400V, I _D = 11A,		22			
Turn-off Delay Time	t _{d(off)}	$R_{\rm G} = 25\Omega$		94		ns	
Turn-off Fall Time	t _f			26			
Drain-Source Body Diode Characte	eristics						
Body Diode Voltage	V _{SD}	T _J = 25°C, I _{SD} = 5.5A, V _{GS} = 0V		1.0	1.5	V	
Reverse Recovery Time	t _{rr}			119		ns	
Reverse Recovery Charge	Q _{rr}	V _R = 400V, I _F = I _S , di _F /dt = 100A/µs		0.58		μC	
Peak Reverse Recovery Current	I _{rrm}			9.8		А	

Notes

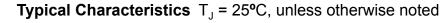
- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. I_{AS} = 1.8A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25°C
- 3. Identical low side and high side switch with identical ${\rm R}_{\rm G}$

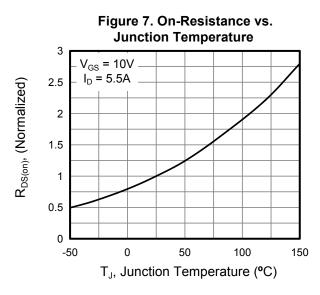


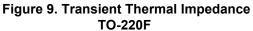
Typical Characteristics $T_J = 25^{\circ}C$, unless otherwise noted

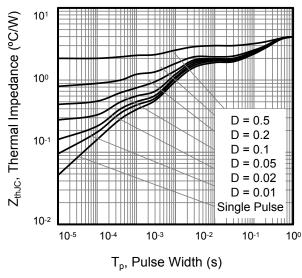


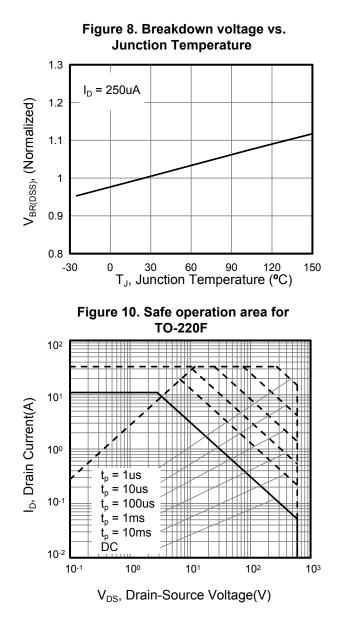
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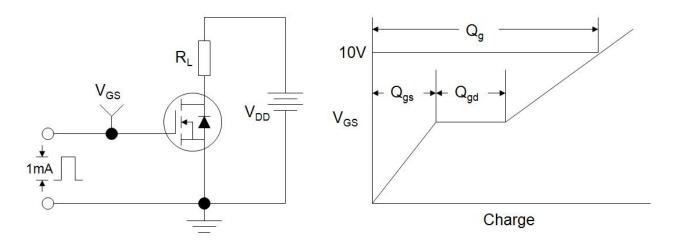


Figure B: Resistive Switching Test Circuit and Waveform

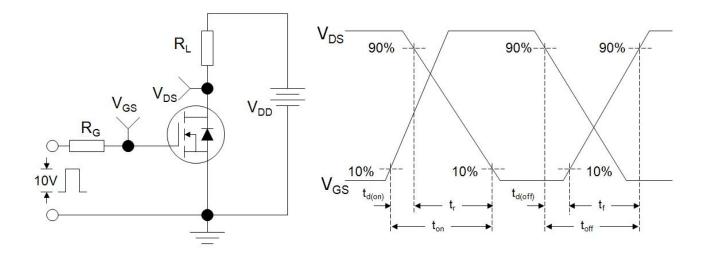
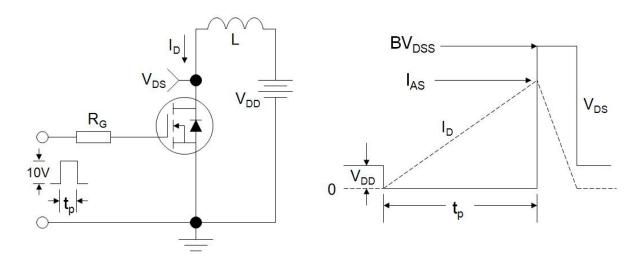
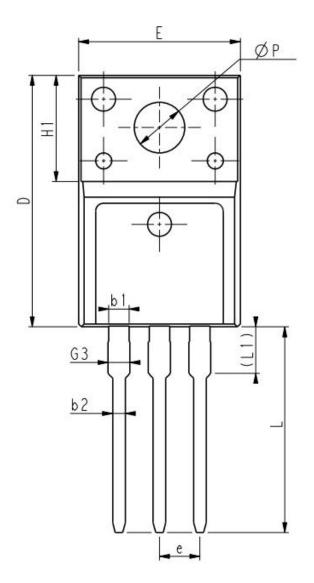


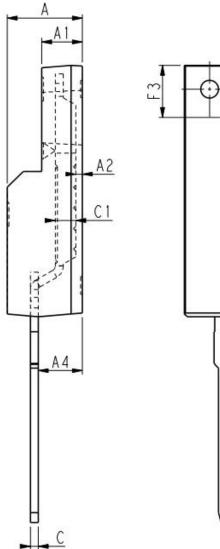
Figure C: Unclamped Inductive Switching Test Circuit and Waveform

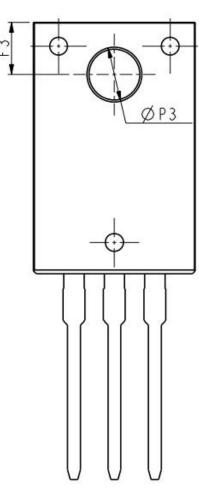












	Unit:mm				
Symbol	Max.	Nom	Min.	Symbol	
е	10.36	10.16	9.96	E	
L	4.90	4.70	4.50	А	
L1	2.74	2.54	2.34	A1	
ΦP	0.60	0.45	0.30	A2	
ΦP3	2.96	2.76	2.56	A4	
F3	0.65	0.50	0.40	С	
G3	1.35	1.30	1.20	c1	
b1	16.17	15.87	15.57	D	
b2	6.70REF			H1	

Unit:mm					
Symbol	Min.	Nom	Max.		
е	2.54BSC				
L	12.68	12.98	13.28		
L1	2.93	3.03	3.13		
ΦΡ	3.03	3.18	3.38		
ΦΡ3	3.15	3.45	3.65		
F3	3.15	3.30	3.45		
G3	1.25	1.35	1.55		
b1	1.18	1.28	1.43		
b2	0.70	0.80	0.95		



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